High Performance Stereo Audio DAC

FEATURES

- High performance and low power multi-bit delta-sigma audio DAC
- 110 dB signal to noise ratio, -80 dB THD+N
- 24-bit, 8 to 96 kHz sampling frequency
- Integrated headphone driver with capless option
- Differential output for higher SNR and CMRR
- I^{2}S/PCM master or slave serial data port
- 256/384Fs, USB 12/24 MHz and other non standard audio system clocks
- I^{2}C interface
- 7-band fully adjustable EQ
- Dynamic range compression
- Playback signal feedback
- Pop and click noise suppression
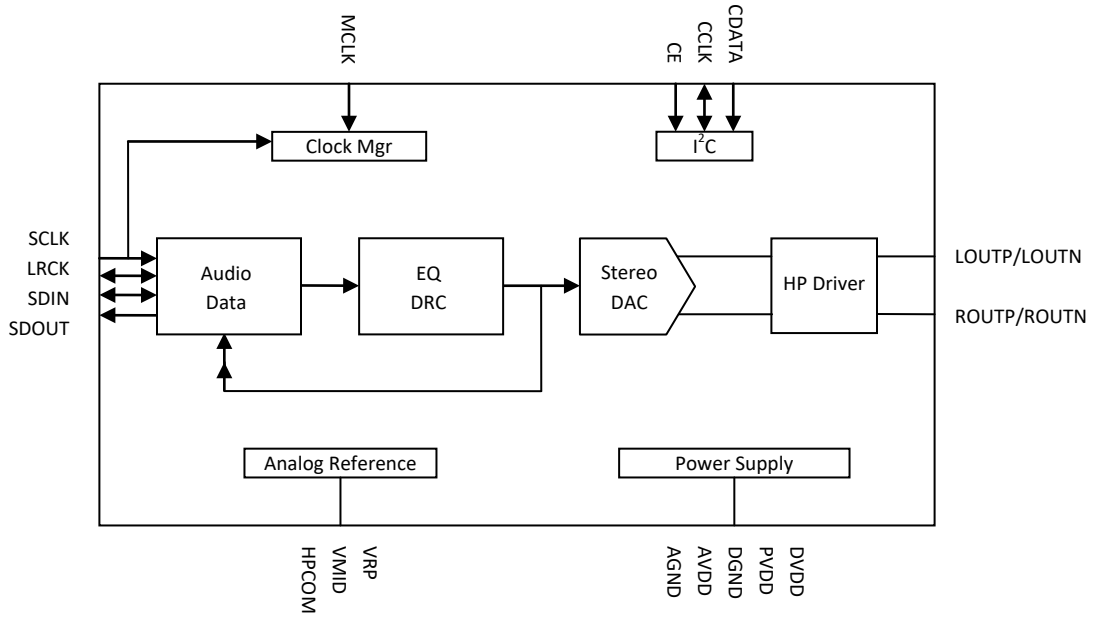- 1.8V to 3.3V operation

APPLICATIONS
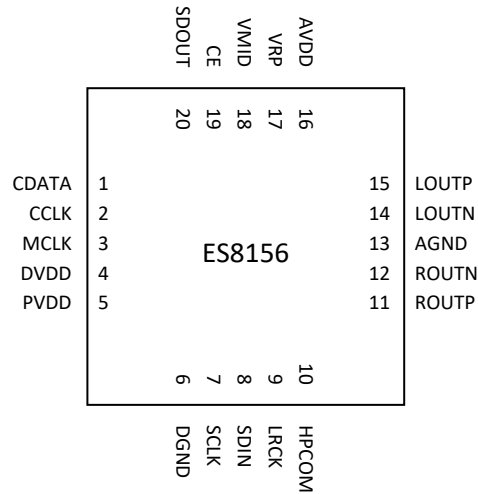
- Headphone
- Speaker
- TV
- Portable audio devices

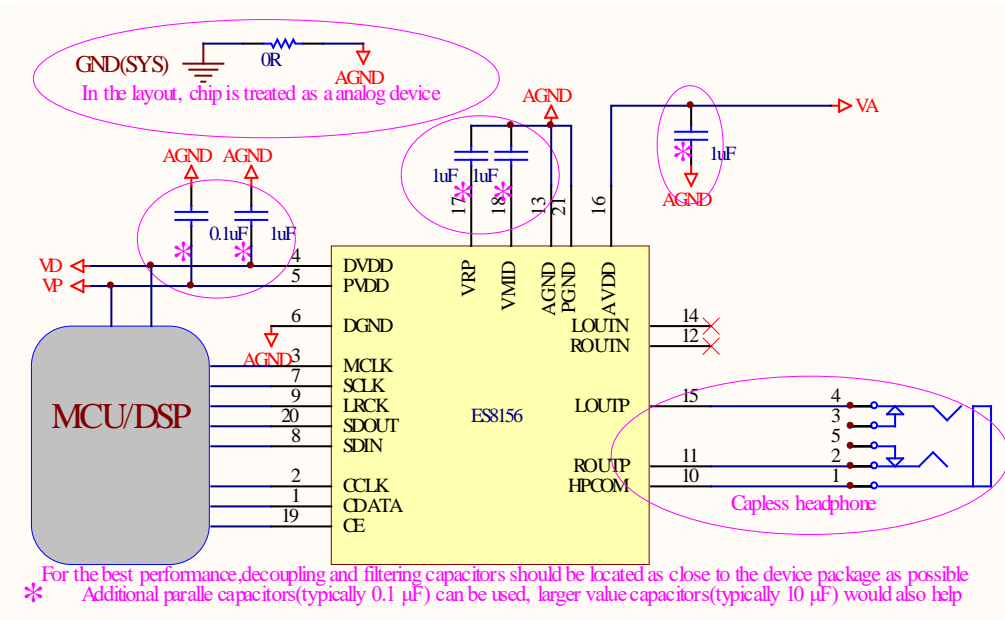## ORDERING INFORMATION
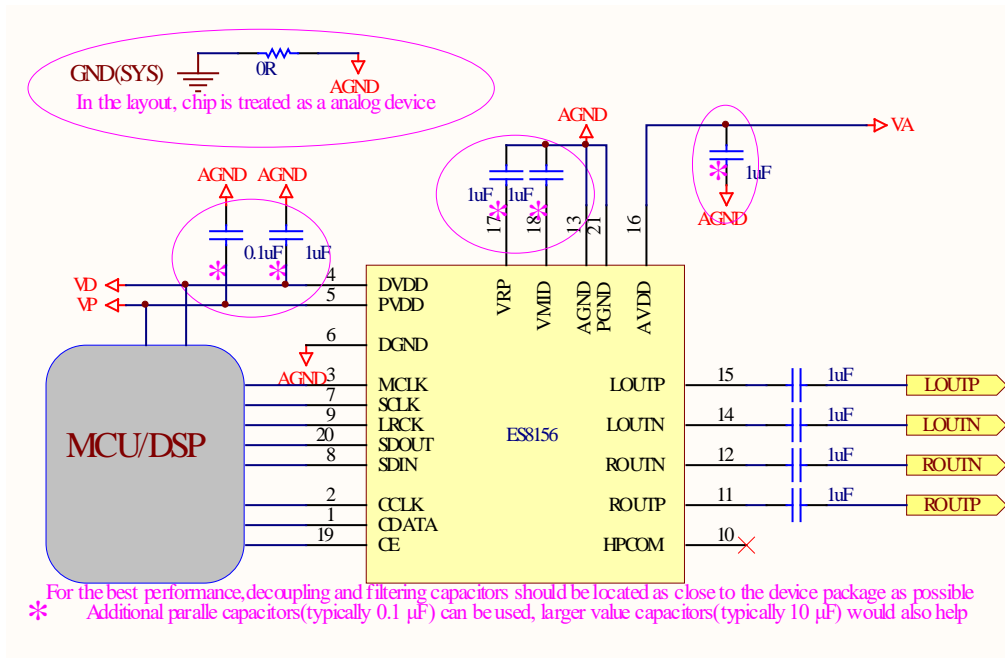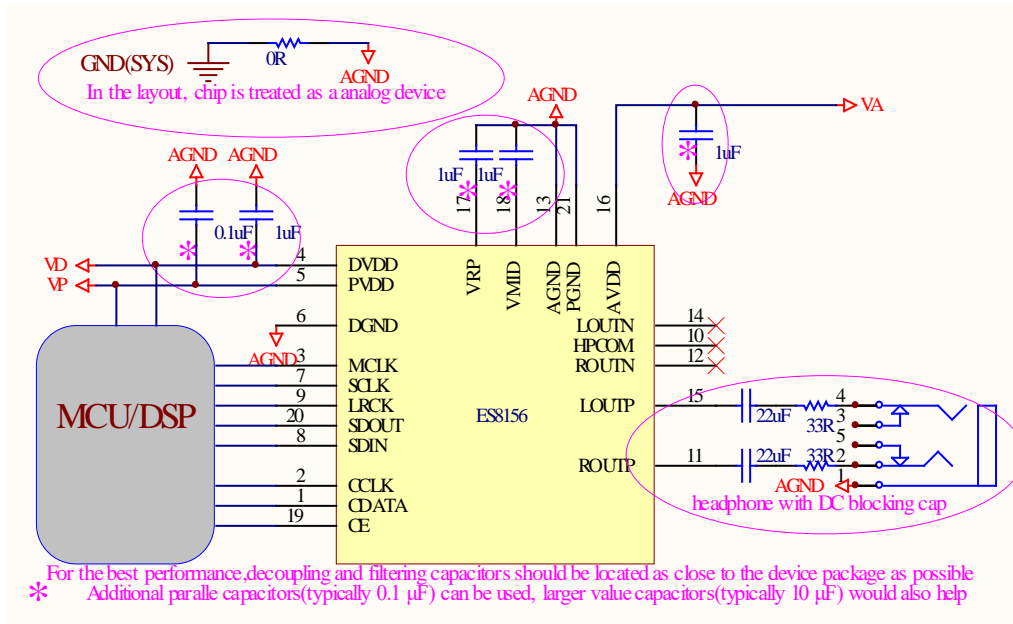
ES8156 -40°C ~ +85°C
QFN-20

1. BLOCK DIAGRAM

2. PIN OUT AND DESCRIPTION

```
                    SDOUT  CE  VMID  VRP  AVDD

                     20   19   18   17   16

       CDATA  │ 1                          15 │  LOUTP
        CCLK   │ 2                          14 │  LOUTN
        MCLK   │ 3          ES8156          13 │  AGND
        DVDD   │ 4                          12 │  ROUTN
        PVDD   │ 5                          11 │  ROUTP

                      6    7    8    9    10

                    DGND  SCLK  SDIN  LRCK  HPCOM
```

Pin Name	Pin number	Input or Output	Pin Description
CDATA, CCLK, CE	1, 2, 19	I/O, I, I	I^{2}C clock, data, address
MCLK	3	I	Master clock
SCLK	7	I/O	Serial data bit clock/DMIC bit clock
SDIN	8	I	DAC serial data input
LRCK	9	I/O	Serial data left and right channel frame clock
SDOUT	20	O	Playback signal feedback
LOUTP, LOUTN	15, 14	O	Left channel differential analog output
ROUTP, ROUTN	11, 12	O	Right channel differential analog output
HPCOM	10	Analog	Virtual ground for capless headphone (Only available in software mode)
PVDD	5	Analog	Power supply for the digital input and output
DVDD, DGND	4, 6	Analog	Digital power supply
AVDD, AGND	16, 13	Analog	Analog power supply
VMID	18	Analog	Filtering capacitor connection
VRP	17	Analog	Filtering capacitor connection

3. TYPICAL APPLICATION CIRCUIT

For the best performance,decoupling and filtering capacitors should be located as close to the device package as possible
✱   Additional paralle capacitors(typically 0.1 μF) can be used, larger value capacitors(typically 10 μF) would also help

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GND(SYS) 0R AGND
In the layout, chip is treated as a analog device

AGND

VA

1uF 1uF
1uF

AGND

AGND AGND

0.1uF 1uF

VD	4 DVDD
VP	5 PVDD

17 VRP
18 VMID
13 AGND
21 PGND
16 AVDD

6	DGND

MCU/DSP

AGND 3 MCLK
7 SCLK
9 LRCK
20 SDOUT
8 SDIN

ES8156

2 CCLK
1 CDATA
19 CE

14 LOUTN
10 HPCOM
12 ROUTN

15 LOUTP 22uF 33R 4 3 5
11 ROUTP 22uF 33R 2 1
AGND
headphone with DC blocking cap

For the best performance,decoupling and filtering capacitors should be located as close to the device package as possible
* Additional paralle capacitors(typically 0.1 µF) can be used, larger value capacitors(typically 10 µF) would also help

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4. HARDWARE MODE

The device works either in hardware mode (HW mode) or software mode (I^{2}C mode). The default is hardware mode. Software mode is enabled by setting bit 2 of configuration register 0x02.

In HW mode, LRCK and SCLK are supplied externally. LRCK and SCLK must be synchronously derived from the system clock with some specific rates. The device can auto detect MCLK/LRCK ratio according to Table 1. The device only supports the MCLK/LRCK ratios listed in Table 1. The SCLK/LRCK ratio is normally 64.

Table 1 Slave Mode Sampling Frequencies and MCLK/LRCK Ratio

Speed Mode	Sampling Frequency	MCLK/LRCK Ratio
Single Speed	8kHz – 50kHz	32, 64, 96, 128, 192, 256, 384, 512, 640, 768, 1024, 1152, 1280, 1536

5. CLOCK MODES AND SAMPLING FREQUENCIES

In software mode, the device supports standard audio clocks (32Fs, 64F, 128Fs, 256Fs, 384Fs, 512Fs, etc), USB clocks (12/24 MHz), and some common non standard audio clocks (16 MHz, 25 MHz, 26 MHz, etc).

According to the serial audio data sampling frequency (Fs), the device can work in two speed modes: single speed mode or double speed mode. In single speed mode, Fs normally ranges from 8 kHz to 48 kHz, and in double speed mode, Fs normally range from 64 kHz to 96 kHz.

The device can work either in master clock mode or slave clock mode. In slave mode, LRCK and SCLK are supplied externally, and LRCK and SCLK must be synchronously derived from the system clock with specific rates. In master mode, LRCK and SCLK are derived internally from device master clock.

6. MICRO-CONTROLLER CONFIGURATION INTERFACE

The device supports standard I^{2}C micro-controller configuration interface. External micro-controller can completely configure the device through writing to internal configuration registers.

I^{2}C interface is a bi-directional serial bus that uses a serial data line (CDATA) and a serial clock line (CCLK) for data transfer. The timing diagram for data transfer of this interface is given in Figure 1a and Figure 1b. Data are transmitted synchronously to CCLK clock on the CDATA line on a byte-by-byte basis. Each bit in a byte is sampled during CCLK high with MSB bit being transmitted firstly. Each transferred byte is followed by an acknowledge bit from receiver to pull the CDATA low. The transfer rate of this interface can be up to 400 kbps.

A master controller initiates the transmission by sending a "start" signal, which is defined as a high-to-low transition at CDATA while CCLK is high. The first byte transferred is the slave address. It is a seven-bit chip address followed by a RW bit. The chip address must be 0001 00x, where x equals CE. The RW bit indicates the slave data transfer direction. Once an acknowledge bit is received, the data transfer starts to proceed on a byte-by-byte basis in the direction specified by the RW bit. The master can terminate the communication by generating a "stop" signal, which is defined as a low-to-high transition at CDATA while CCLK is high.

In I^2C interface mode, the registers can be written and read. The formats of "write" and "read" instructions are shown in Table 2 and Table 3. Please note that, to read data from a register, you must set R/W bit to 0 to access the register address and then set R/W to 1 to read data from the register.

Table 2 Write Data to Register in I^2C Interface Mode

	Chip Address	R/W		Register Address		Data to be written		
start	0001 00 CE	0	ACK	RAM	ACK	DATA	ACK	Stop
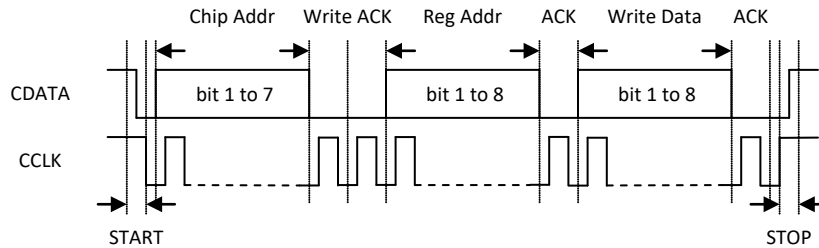
Figure 1a I^2C Write Timing

Table 3 Read Data from Register in I^2C Interface Mode

	Chip Address	R/W		Register Address		
Start	0001 00 CE	0	ACK	RAM	ACK	
	Chip Address	R/W		Data to be read		
Start	0001 00 CE	1	ACK	Data	NACK	Stop

Figure 1b I^2C Read Timing

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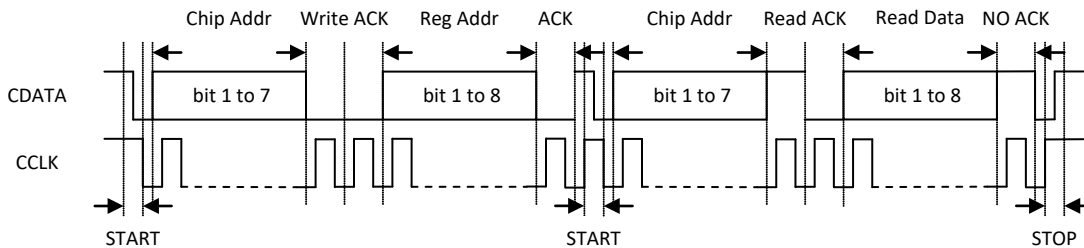## 7. DIGITAL AUDIO INTERFACE

The device provides many formats of serial audio data interface to the input or output through LRCK, SCLK and SDIN or SDOUT pins. These formats are I^{2}S, left justified, right justified and DSP/PCM. SDIN is sampled by the device on the rising edge of SCLK. SDOUT is out on the falling edge of SCLK. The relationship of SDATA (SDIN or SDOUT), SCLK and LRCK with these formats are shown through Figure 2a to Figure 2d.
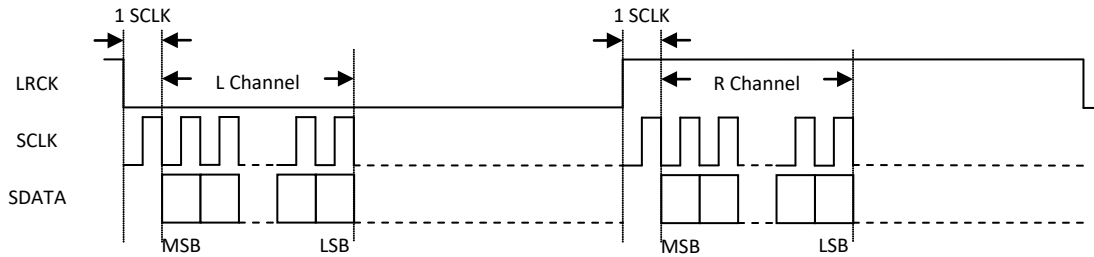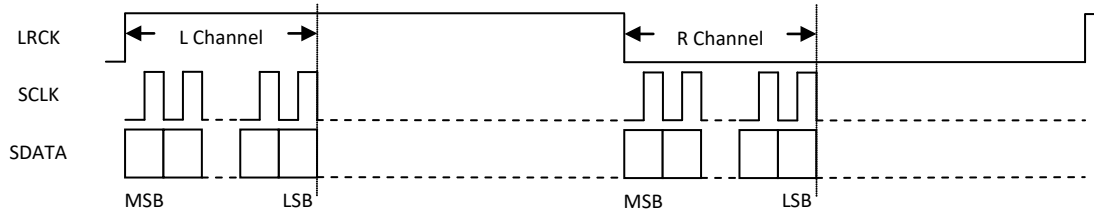
Figure 2a I^{2}S Serial Audio Data Format

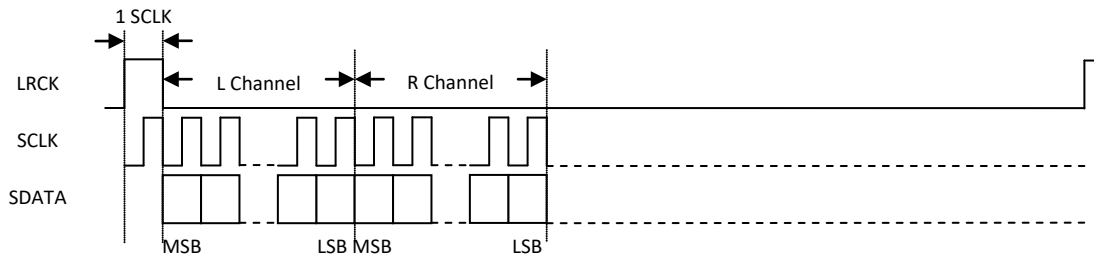Figure 2b Left Justified Serial Audio Data Format

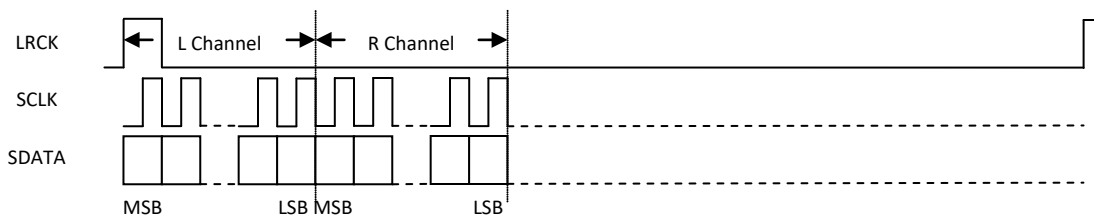Figure 2c DSP/PCM Mode A Serial Audio Data Format

Figure 2d DSP/PCM Mode B Serial Audio Data Format

8. ELECTRICAL CHARACTERISTICS

ABSOLUTE MAXIMUM RATINGS

Continuous operation at or beyond these conditions may permanently damage the device.

PARAMETER	MIN	MAX
Analog Supply Voltage Level	-0.3V	+3.6V
Digital Supply Voltage Level	-0.3V	+3.6V
Analog Input Voltage Range	AGND-0.3V	AVDD+0.3V
Digital Input Voltage Range	DGND-0.3V	PVDD+0.3V
Operating Temperature Range	-40°C	+85°C
Storage Temperature	-65°C	+150°C

RECOMMENDED OPERATING CONDITIONS

PARAMETER	MIN	TYP	MAX	UNIT
DVDD (Note 1)	1.6	1.8/3.3	3.6	V
PVDD	1.6	1.8/3.3	3.6	V
AVDD (Note 2)	1.7	1.8/3.3	3.6	V

Note 1: if SCLK is input to clock manager, and is less than 1 MHz, DVDD must be lower than 2V.

Note 2: in hardware mode, AVDD must be higher than 3V.

DAC ANALOG AND FILTER CHARACTERISTICS AND SPECIFICATIONS

Test conditions are as the following unless otherwise specify: AVDD=3.3V, DVDD=3.3V, AGND=0V, DGND=0V, Ambient temperature=25°C, Fs=48 KHz, MCLK/LRCK=256.

PARAMETER	MIN	TYP	MAX	UNIT
DAC Performance				
Signal to Noise ratio (A-weigh)	105	110	115	dB
THD+N	-85	-80	-78	dB
Channel Separation (1KHz)	105	110	115	dB
Interchannel Gain Mismatch		0.1		dB
Filter Frequency Response – Single Speed				
Passband	0		0.4535	Fs
Stopband	0.5465			Fs
Passband Ripple			±0.05	dB
Stopband Attenuation	53			dB
Filter Frequency Response – Double Speed				
Passband	0		0.4167	Fs
Stopband	0.7917			Fs
Passband Ripple			±0.005	dB
Stopband Attenuation	56			dB
Analog Output				
Full Scale Output Level (±: differential P/N)		±0.9*AVDD/3.3		±Vrms

DC CHARACTERISTICS

PARAMETER	MIN	TYP	MAX	UNIT
Normal Operation Mode				
DVDD=1.8V, PVDD=1.8V, AVDD=3.3V DVDD=1.8V, PVDD=1.8V, AVDD=1.8V		19 6		mW
Power Down Mode (Note 3)				
DVDD=1.8V, PVDD=1.8V, AVDD=3.3V		0		uA
Digital Voltage Level				
Input High-level Voltage	0.7*PVDD			V
Input Low-level Voltage			0.5	V
Output High-level Voltage		PVDD		V
Output Low-level Voltage		0		V

Note 3: recommend all power supply on, entering low power through control register setting, then stopping input clock.

I²C SWITCHING SPECIFICATIONS (SLOW SPEED MODE/HIGH SPEED MODE)

PARAMETER	Symbol	MIN	MAX	UNIT
CCLK Clock Frequency	F_{CCLK}		100/400	KHz
Bus Free Time Between Transmissions	T_{TWID}	4.7/1.3		us
Start Condition Hold Time	T_{TWSTH}	4.0/0.6		us
Clock Low time	T_{TWCL}	4.7/1.3		us
Clock High Time	T_{TWCH}	4.0/0.6		us
Setup Time for Repeated Start Condition	T_{TWSTS}	4.7/0.6		us
CDATA Hold Time from CCLK Falling	T_{TWDH}		3.45/0.9	us
CDATA Setup time to CCLK Rising	T_{TWDS}	0.25/0.1		us
Rise Time of CCLK	T_{TWR}		1.0/0.3	us
Fall Time CCLK	T_{TWF}		1.0/0.3	us
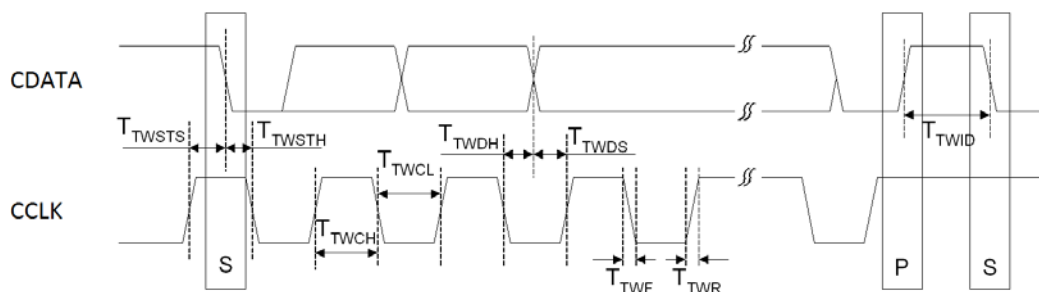
Figure 3 I²C Timing

SERIAL AUDIO PORT SWITCHING SPECIFICATIONS

PARAMETER		Symbol	MIN	MAX	UNIT
MCLK frequency				49.2	MHz
MCLK duty cycle			40	60	%
LRCK frequency				100	KHz
LRCK duty cycle (Note 4)			40	60	%
SCLK frequency				26	MHz
SCLK pulse width low		T_{SLKL}	16		ns
SCLK Pulse width high		T_{SCLKH}	16		ns
SCLK falling to LRCK edge (master mode only)		T_{SLR}		10	ns
LRCK edge to SCLK rising (slave mode only)		T_{LSR}	10		ns
SCLK falling to SDOUT valid	VDDD=3.3V	T_{SDO}		16	ns
	VDDD=1.8V			39	
LRCK edge to SDOUT valid (Note 5)	VDDD=3.3V	T_{LDO}		11	ns
	VDDD=1.8V			25	
SDIN valid to SCLK rising setup time		T_{SDIS}	10		ns
SCLK rising to SDIN hold time		T_{SDIH}	10		ns

Note 4: one SCLK period of high time in DSP/PCM modes.

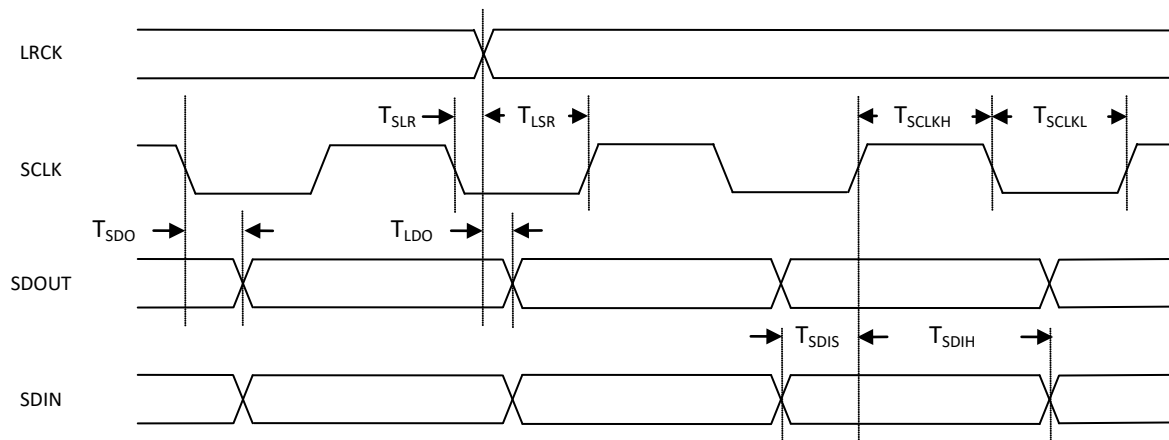Note 5: only apply to MSB of Left Justified or DSP/PCM mode B.

Figure 4 Serial Audio Port Timing

9. PACKAGE (UNIT: MM)

	SYMBOL	MIN	NOM	MAX
TOTAL THICKNESS	A	0.5	0.55	0.6
STAND OFF	A1	0	0.02	0.05
MOLD THICKNESS	A2	----	0.4	----
L/F THICKNESS	A3		0.152 REF	
LEAD WIDTH	b	0.15	0.2	0.25
BODY SIZE X	D		3 BSC	
BODY SIZE Y	E		3 BSC	
LEAD PITCH	e		0.4 BSC	
EP SIZE X	D2	1.6	1.7	1.8
EP SIZE Y	E2	1.6	1.7	1.8
LEAD LENGTH	L	0.2	0.3	0.4
LEAD TIP TO EXPOSED PAD EDGE	K		0.35 REF	
PACKAGE EDGE TOLERANCE	aaa		0.1	
MOLD FLATNESS	ccc		0.1	
COPLANARITY	eee		0.08	
LEAD OFFSET	bbb		0.1	
EXPOSED PAD OFFSET	fff		0.1	

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10.CORPORATE INFORMATION

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